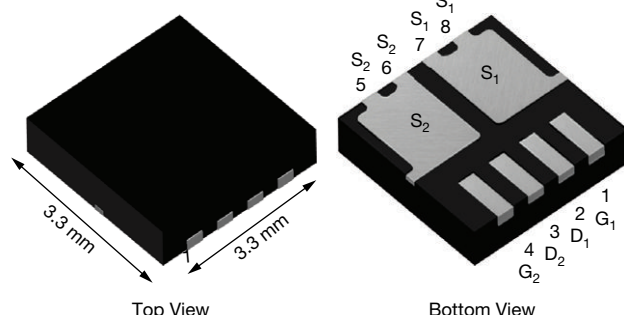


Common - Drain Dual N-Channel 60 V (S1-S2) MOSFET

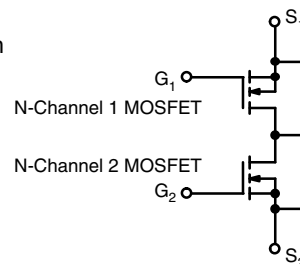
PowerPAK® 1212-8SCD

RoHS
COMPLIANT
HALOGEN
FREE

FEATURES

- TrenchFET® Gen IV power MOSFET
- Very low source-to-source on resistance
- Integrated common-drain n-channel MOSFETs in a compact and thermally enhanced package
- 100 % R_g and UIS tested
- Optimizes circuit layout for bi-directional current flow
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- Battery protection switch
- Bi-directional switch
- Load switch
- 24 V systems



PRODUCT SUMMARY	
V_{S1S2} (V)	60
$R_{S1S2(on)}$ max. (Ω) at $V_{GS} = 10$ V	0.0130
$R_{S1S2(on)}$ max. (Ω) at $V_{GS} = 4.5$ V	0.0185
Q_g typ. (nC)	10.2 ^g
I_{S1S2} (A)	52 ^a
Configuration	Common - Drain

ORDERING INFORMATION

Package	PowerPAK 1212-8SCD
Lead (Pb)-free and halogen-free	SiSF20DN-T1-GE3

ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C, unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-source voltage	V_{S1S2}	60	V
Gate-source voltage	V_{GS}	± 20	
Continuous drain current ($T_J = 150$ °C)	$T_C = 25$ °C	52	A
	$T_C = 70$ °C	41	
	$T_A = 25$ °C	14 ^{b, c}	
	$T_A = 70$ °C	11 ^{b, c}	
Pulsed drain current ($t = 100$ μ s)	I_{S1S2M}	100	
Maximum power dissipation	$T_C = 25$ °C	69.4	W
	$T_C = 70$ °C	44.4	
	$T_A = 25$ °C	5.2 ^{b, c}	
	$T_A = 70$ °C	3.3 ^{b, c}	
Operating junction and storage temperature range	T_J, T_{stg}	-55 to +150	°C
Soldering recommendations (peak temperature) ^c		260	

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum junction-to-ambient ^b	R_{thJA}	19	24	°C/W
Maximum junction-to-case (drain)	R_{thJC}	1.4	1.8	

Notes

- $T_C = 25$ °C
- Surface mounted on 1" x 1" FR4 board
- $t = 10$ s
- See solder profile (www.vishay.com/doc?73257). The PowerPAK 1212-8SCD is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- Maximum under steady state conditions is 63 °C/W
- Single MOSFET



SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-source breakdown voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	60	-	-	V
Gate-source threshold voltage	V _{GS(th)}	V _{S1S2} = V _{GS} , I _D = 250 μA	1	-	3	
Gate-source leakage	I _{GSS}	V _{S1S2} = 0 V, V _{GS} = ± 20 V	-	-	± 100	nA
Zero gate voltage drain current	I _{DSS}	V _{S1S2} = 60 V, V _{GS} = 0 V	-	-	1	μA
		V _{S1S2} = 60 V, V _{GS} = 0 V, T _J = 70 °C	-	-	15	
On-state drain current ^a	I _{S1S2(on)}	V _{S1S2} ≥ 10 V, V _{GS} = 10 V	20	-	-	A
Drain-source on-state resistance ^a	R _{S1S2(on)}	V _{GS} = 10 V, I _{S1S2} = 7 A	-	0.0100	0.0130	Ω
		V _{GS} = 4.5 V, I _{S1S2} = 5 A	-	0.0140	0.0185	
Forward transconductance ^a	g _{fs}	V _{S1S2} = 10 V, I _{S1S2} = 25 A	-	75	-	S
Dynamic ^{b, c}						
Input capacitance	C _{iss}	V _{DS} = 30 V, V _{GS} = 0 V, f = 1 MHz	-	1290	-	pF
Output capacitance	C _{oss}		-	340	-	
Reverse transfer capacitance	C _{rss}		-	8	-	
Total gate charge	Q _g	V _{DS} = 30 V, V _{GS} = 10 V, I _D =5 A	-	22	33	nC
		V _{DS} = 30 V, V _{GS} = 4.5 V, I _D = 5 A	-	10.2	16	
Gate-source charge	Q _{gs}		-	3.9	-	
Gate-drain charge	Q _{gd}	-	2.9	-		
Gate resistance	R _g	f = 1 MHz	0.14	0.7	1.4	Ω
Turn-on delay time	t _{d(on)}	V _{DD} = 30 V, R _L = 6 Ω, I _{S1S2} ≅ 5 A, V _{GEN} = 10 V, R _g = 1 Ω	-	10	20	ns
Rise time	t _r		-	5	10	
Turn-off delay time	t _{d(off)}		-	19	40	
Fall time	t _f		-	5	10	
Turn-on delay time	t _{d(on)}	V _{DD} = 30 V, R _L = 6 Ω, I _D ≅ 5 A, V _{GEN} = 4.5 V, R _g = 1 Ω	-	15	30	
Rise time	t _r		-	50	100	
Turn-off delay time	t _{d(off)}		-	24	50	
Fall time	t _f		-	7	15	
Drain-Source Body Diode Characteristics ^c						
Continuous source-drain diode current	I _{S1S2}	T _C = 25 °C	-	-	52	A
Pulse diode forward current	I _{S1S2M}		-	-	100	
Body diode reverse recovery time	t _{rr}	I _F = 5 A, di/dt = 100 A/μs, T _J = 25 °C	-	30	60	ns
Body diode reverse recovery charge	Q _{rr}		-	18	35	nC
Reverse recovery fall time	t _a		-	15	-	ns
Reverse recovery rise time	t _b		-	15	-	

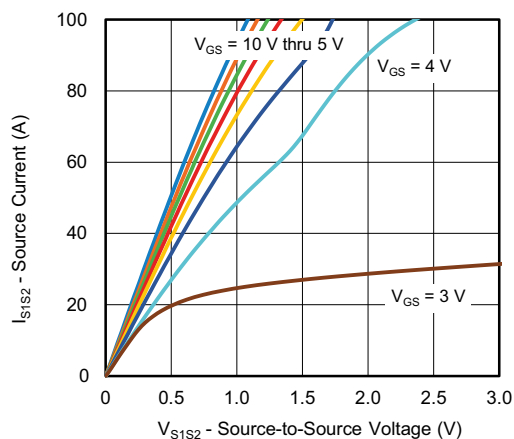
Notes

- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$
b. Guaranteed by design, not subject to production testing
c. On single MOSFET

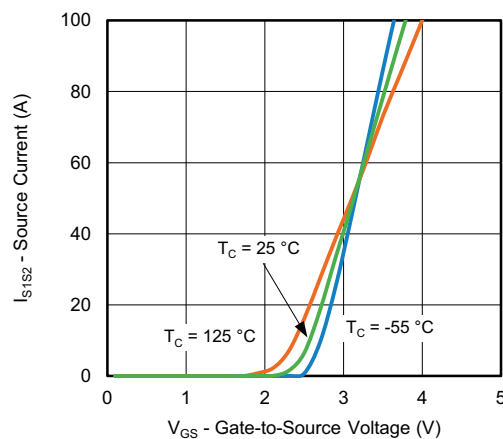
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



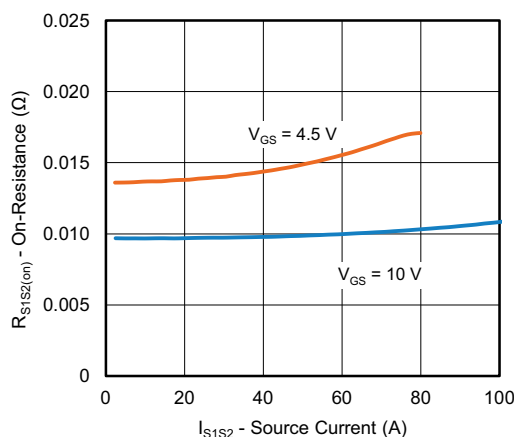
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



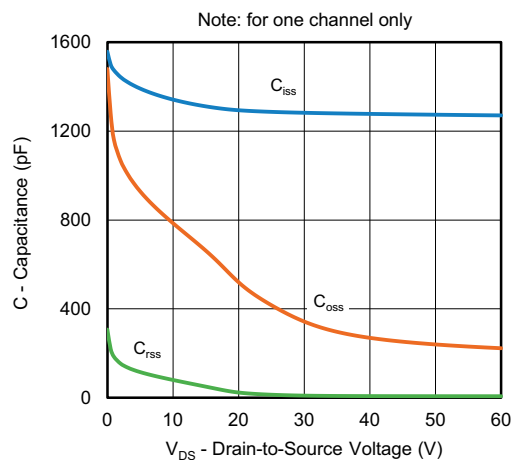
Output Characteristics



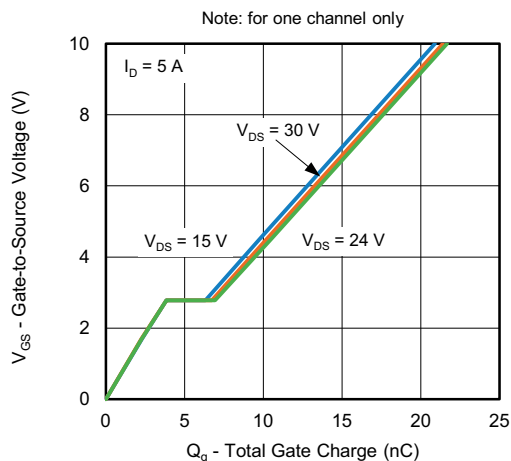
Transfer Characteristics



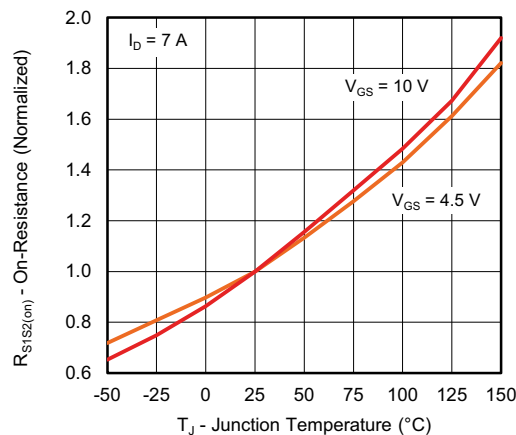
On-Resistance vs. Source Current and Gate Voltage



Capacitance



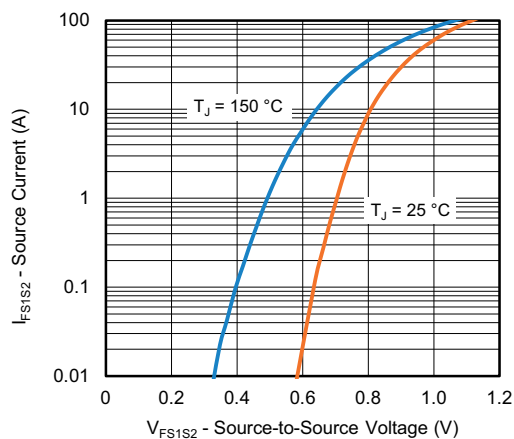
Gate Charge



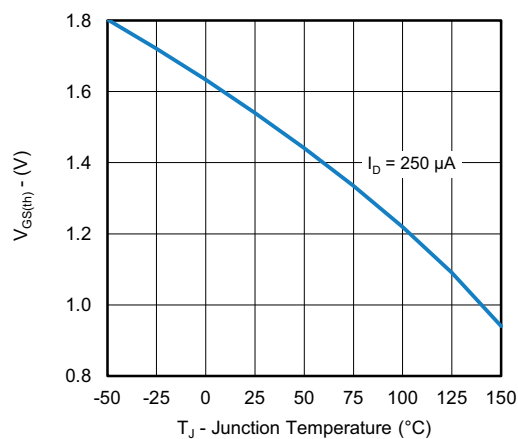
On-Resistance vs. Junction Temperature



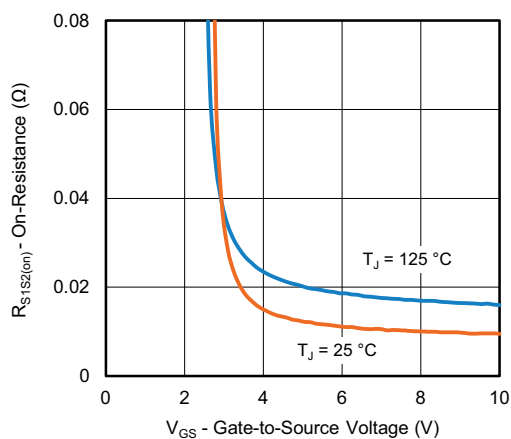
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



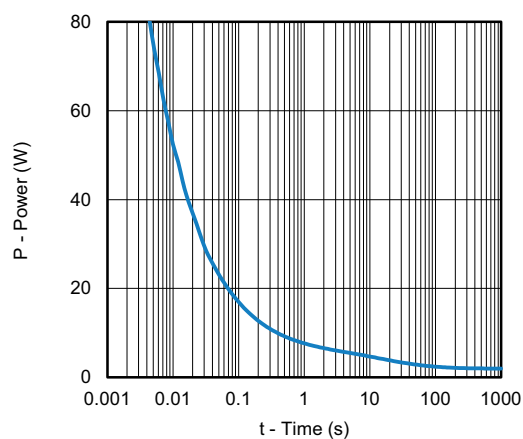
Source-Drain Diode Forward Voltage



Threshold Voltage



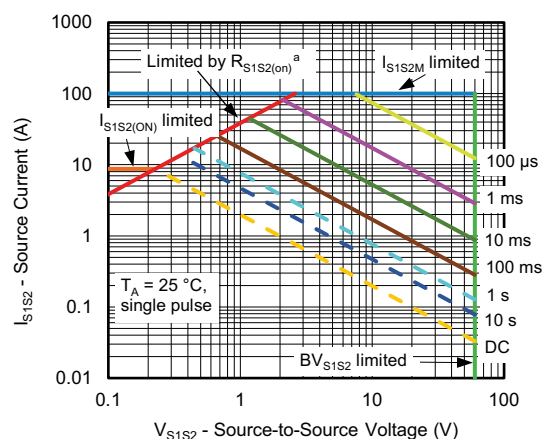
On-Resistance vs. Gate-to-Source Voltage



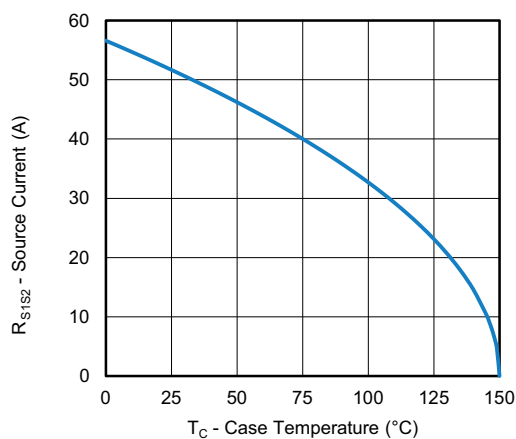
Single Pulse Power, Junction-to-Ambient



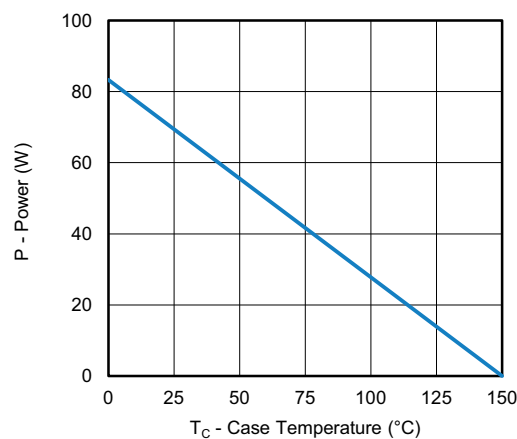
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Safe Operating Area, Junction-to-Ambient



Current Derating ^b



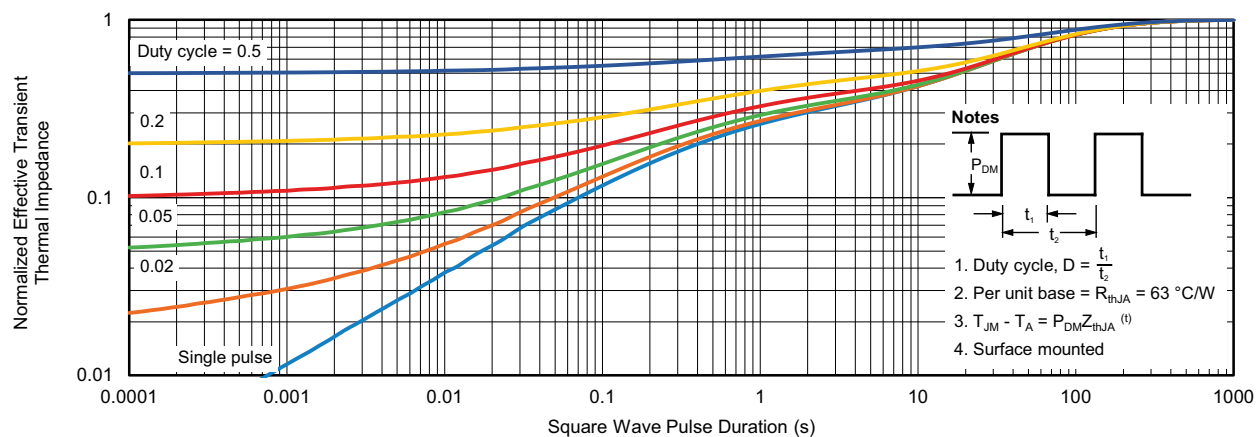
Power, Junction-to-Case

Notes

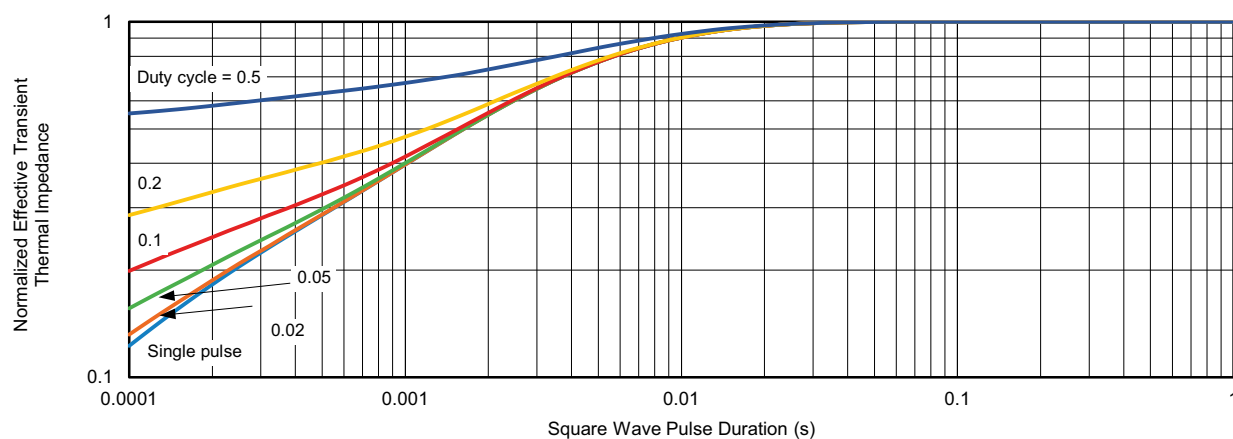
- $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified
- The power dissipation P_D is based on $T_J \text{ max.} = 150\text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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